

DIN-Signal high current m, 40A solder



Part number	09 03 000 6127
Specification	DIN-Signal high current m, 40A solder
HARTING eCatalogue	https://harting.com/09030006127

Image is for illustration purposes only. Please refer to product description.

Identification

Category	Contacts
Series	DIN 41612
	har-modular [®]
Type of contact	PCB solder contact
Description of the contact	Angled
Contacts for	DIN 41612 Type M
	DIN 41612 Type MH 21+5
	DIN 41612 Bauform M 0+2
	har-modular [®] M module, male, angled

Version

Termination method	Solder termination
Gender	Male contact for male connectors
Connection type	Motherboard to daughtercard Mezzanine Extender card PCB to cable
Manufacturing process	Turned contacts

Technical characteristics

Rated current	≤40 A
Insertion force	≤10 N
Withdrawal force	≥1.6 N
Performance level	1



Technical characteristics

Mating cycles	≥500	
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Material properties

Material (contacts)	Copper alloy
Surface (contacts)	Noble metal over Ni Mating side Sn over Ni Termination side
RoHS	compliant with exemption
RoHS exemptions	6(c): Copper alloy containing up to 4 % lead by weight
ELV status	compliant with exemption
China RoHS	50
REACH Annex XVII substances	Not contained
REACH ANNEX XIV substances	Not contained
REACH SVHC substances	
TEXTOTI OVITO CUDOCUTICOS	Yes
REACH SVHC substances	Yes Lead
REACH SVHC substances	Lead

Specifications and approvals

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Commercial data

Packaging size	30
Net weight	3.175 g
Country of origin	Germany
European customs tariff number	85366990
GTIN	5713140003903
ETIM	EC000796
eCl@ss	27440204 Contact for industrial connectors



Current carrying capacity

60512-5-2

The current carrying capacity of the connectors is limited by the thermal load capability of the contact element material including the connections and the insulating parts. The derating curve is therefore valid for currents which flow constantly (non-intermittent) through each contact element of the connector evenly, without exceeding the allowed maximum temperature.

Measuring and testing techniques acc. to IEC

